

Quasiparticle Diffusion in CRESST Light Detectors

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1 Introduction

- TES and Phonon Collectors
- Signal evolution in TES systems
- Phonon Collectors

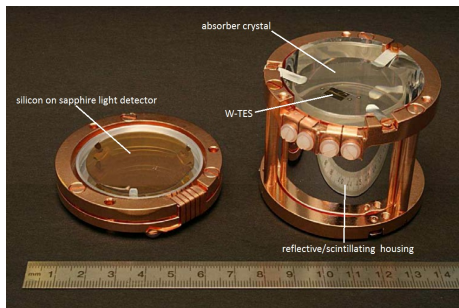
2 Measurement of the diffusion length in CRESST like light detectors

- General Setup
- Simulation of the setup
- Measurement and Analysis
- Results

3 Summary

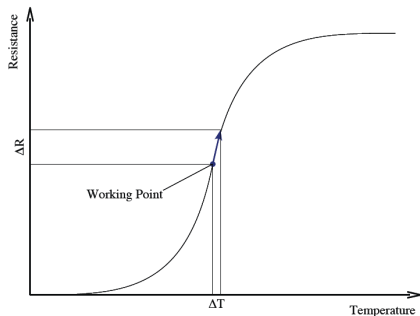
Transition Edge Sensors

- Transition Edge Sensors (TES) common tool to measure precisely energy depositions in a absorber
- TES are sensitive to tiny temperature changes ($\Theta(\mu K)$) in the absorber if operated in the mK scale



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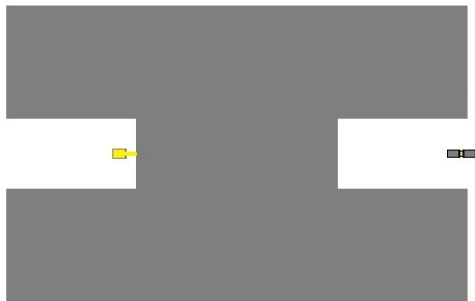


Setup for CRESST TES



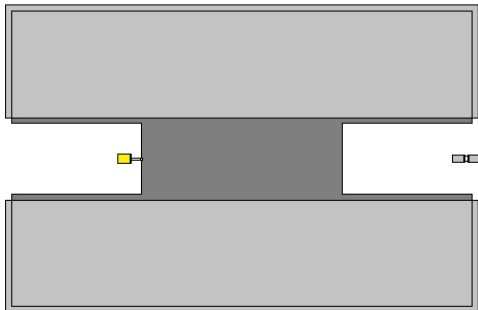
- W layer (100nm-200nm) serving as TES with T_C between 15-20mK

TES setup for CRESST



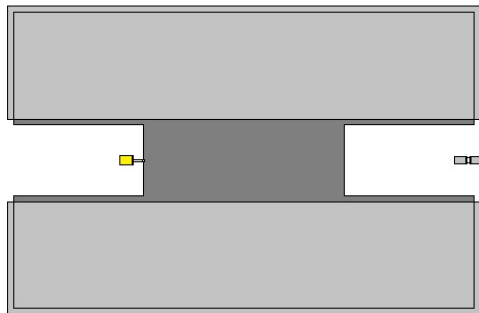
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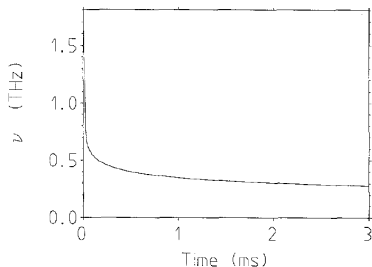
5-6 days of production

Signal evolution in TES systems

- 1 Energy deposition in the absorber \Rightarrow Phonon production and evolution in the absorber
- 2 Transmission of the phonons from the absorber into the TES/PC
- 3 Phonon interactions in the TES
- 4 Phonon interactions in the PC

Signal evolution in TES systems: Energy deposition in the absorber

- recoils produce high frequency optical phonons with a broad frequency distribution (\mathcal{O} (10 THz))
- within 10 μs the phonons decay rapidly to acoustic phonons with a moderate frequency (\mathcal{O} (0.5 GHz))
- due to surface scatter and crystal inhomogeneities the absorber is completely populated with non-thermal phonons
- non-thermal phonons have lifetime of some ms and decay very slowly to smaller frequencies



Signal evolution in TES system: Phonon transmission into the TES

- Transmission of the non-thermal phonons into the TES/PC

$$Q_{A \rightarrow T} \propto \frac{1}{2} \cdot \left\langle \frac{E}{V_A} \right\rangle \cdot \langle \mathbf{v}_{g,\perp} \cdot \boldsymbol{\alpha} \rangle$$

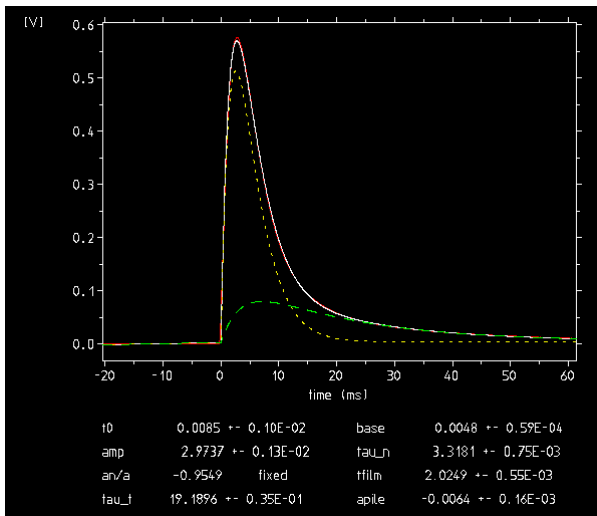
- for the materials used in CRESST LDs the transmission values are between 60%-70%
- influence of the absorber volume to the transmission explains CRESST strategy towards smaller crystals to lower energy threshold

Signal evolution in TES system

Phonon interaction in the TES

- interaction of thermal phonons is strongly suppressed due to T^5 dependence
- Absorption of transverse phonons $\propto \nu \Rightarrow$ strongly suppressed
- Absorption of longitudinal phonons $\propto \nu^2 \Rightarrow$ complete absorption and strong coupling to the electron system
- strong electron-electron coupling \Rightarrow homogeneous heating of the TES

Signal composition in a TES



$$T(t) = \Theta(t - t_0) \cdot (A_n \cdot (e^{-t/\tau_n} - e^{-t/t_{in}}) + A_t \cdot (e^{-t/\tau_t} - e^{-t/t_n}))$$

Phonon collectors

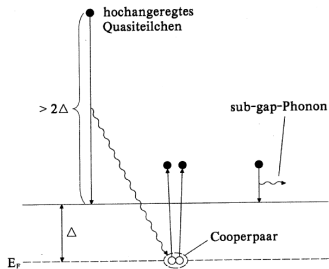
- PC are superconducting parts of the TES that reduce the collection time of non-thermal phonons by increasing the collection area
- The heat capacity is not increased by their addition

$$\tau_{col} = \frac{2V_A}{A \langle v_{g\perp} \cdot \alpha \rangle}$$

$$C_{TES} \propto A$$

Phonon interaction in the phonon collector

- non-thermal phonons break up Cooper Pairs in free electrons (Quasiparticles)
- as long the energy of the QP is above the band gap, more Cooper Pairs are split up
- QP diffuse thermally in the PC until the TES is reached where they can interact with the electron system of the TES

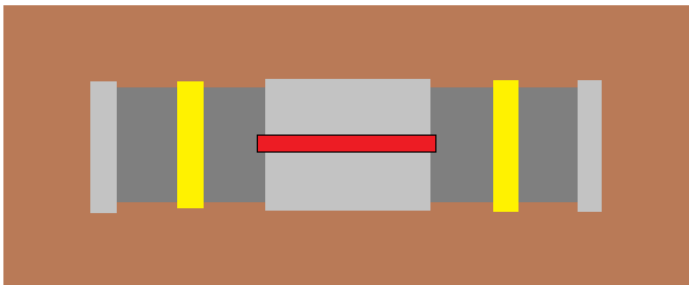


But:

- PCs only influence the TES signal positively if the generated QPs actually reach the TES before their recombination
- The dimensions of the PC have to be adjusted to the diffusion length of the QPs

Measurement

General Setup



- Rad marked area is illuminated by an Fe55 source
- Measurement of the correlated particle signals in the right and left W-TES

Setup

- The number of detected quasiparticles in a detector in a certain distance can be calculated by solving the 1D diffusion equation

$$\frac{\delta n}{\delta t} - D \cdot \frac{\delta^2 n}{\delta x^2} + \frac{n}{\tau_{qp}} = 0 \quad (1)$$

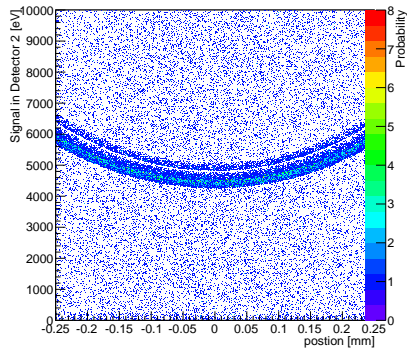
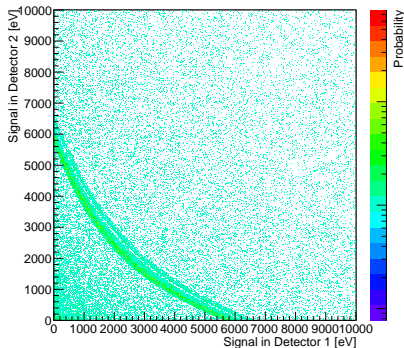
- The solution for the ratio number of detected quasiparticles in one detector is calculated to be

$$n_{1,2}(x_a) = \frac{\sinh(\alpha(0.5 \pm \frac{x_a}{L})) + \beta \cosh(\alpha(0.5 \pm \frac{x_a}{L}))}{(1 + \beta^2) \sinh(\alpha) + 2\beta \cosh(\alpha)} \quad (2)$$

with $\alpha = \frac{L}{\sqrt{D \cdot \tau_{qp}}}$ and $\beta = \frac{\tau_{tr}}{\tau_{qp}}$

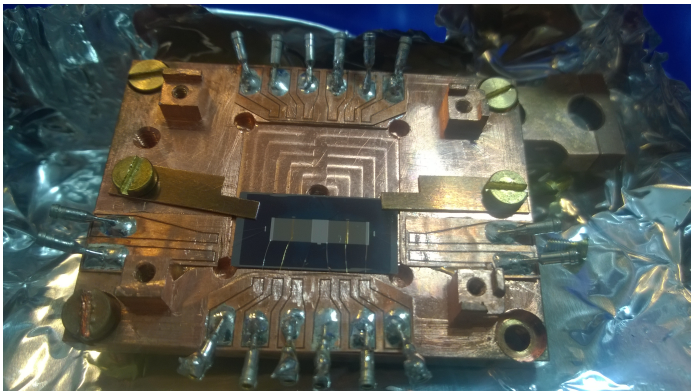
Simulation of the setup

- Simulation of the detector response with a randomly distributed ^{55}Fe spectrum and realistic diffusion parameters



Measurement

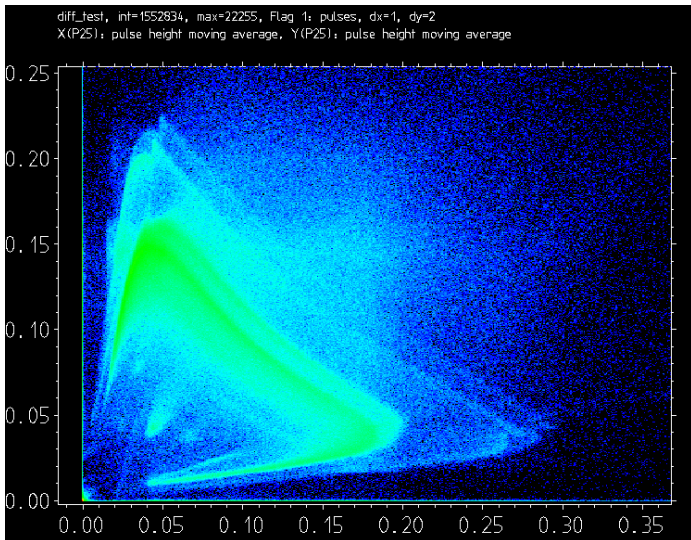
- Si substrate equipped with two TES with the same layer properties like CRESST light detectors



- Setup allows diffusion over a distance of 2mm

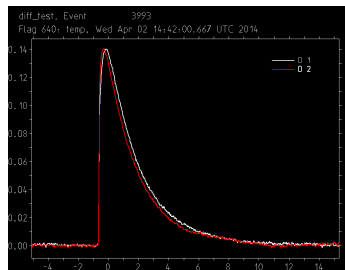
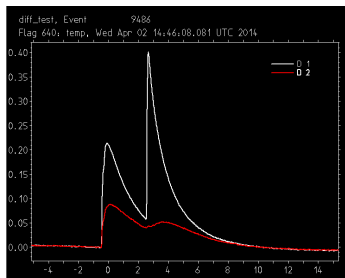
Analysis

- raw data



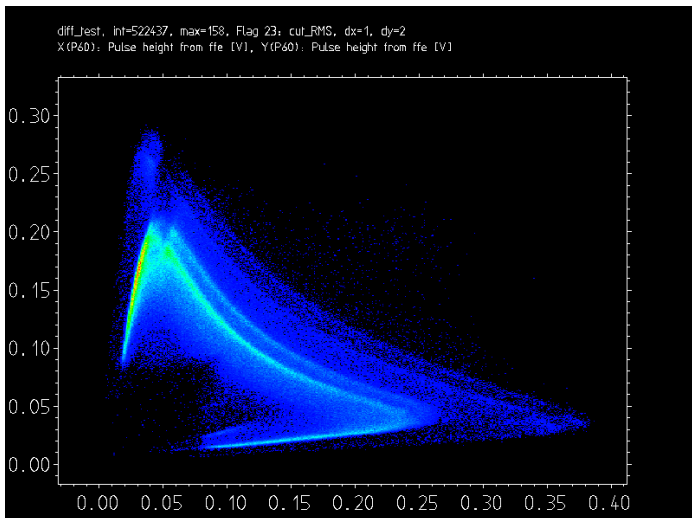
Analysis

- selection of good pulses (removing pile up events, SQUID artefacts,....)



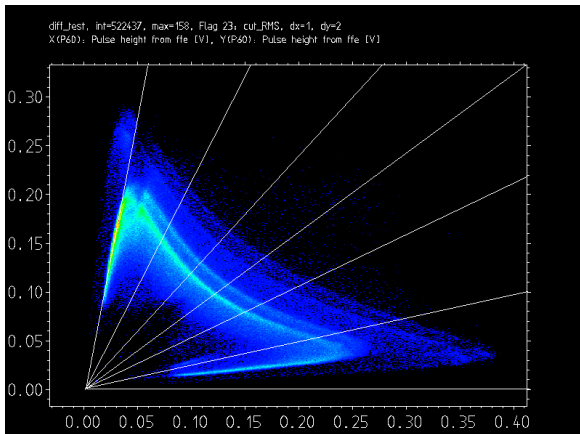
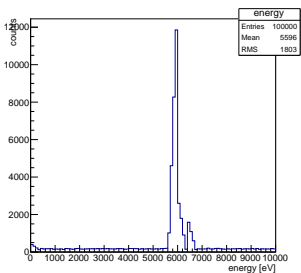
Analysis

- cutted data (all events poluted with measurement artefacts are removed)



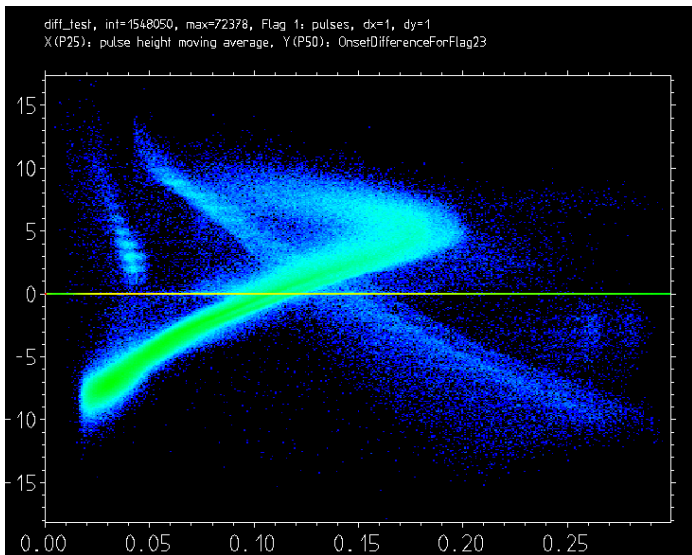
- distinct event classes: substrate hits, PC hits, direct TES hits

Event selection



Event discrimination

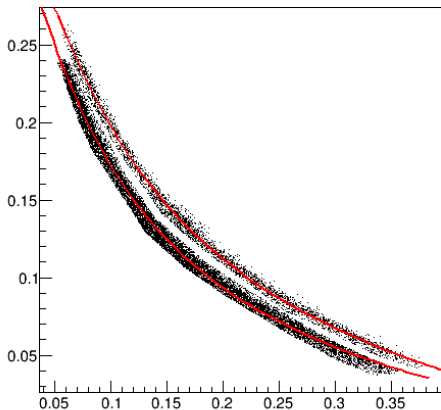
- separation of PC hits and substrate hits necessary \Rightarrow discrimination possible onset difference



Event discrimination

- after isolating the respective particle populations, fit of the data to determine diffusion parameters

Data from RUN443

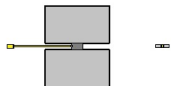
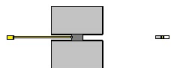


Results

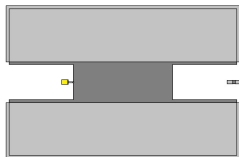
- 4 independent measurements with different substrates reproduced the diffusion parameters
- the measured diffusion length stays between 1-2mm
- the diffusion length is strongly dependent on the quality of the Al phonon collectors (RRR)

=> Diffusion length is much longer than expected

Influence on future CRESST detectors



- in future CRESST detectors the size of the PC is increased relative to the TES size
- first measurements show that 200% more PC area increases the signal height by 30%



Summary

- The efficiency of TES can be increased significantly by the addition of phonon collectors
- The diffusion parameters of the generated Quasiparticles have to be determined for the respective detector setup
- The diffusion length is determining the dimensions of the PC

=> Underestimation of the QP diffusion in CRESST light detectors

=> Next-generation TES are adjusted to the new results by bigger phonon collectors

Thank you!